



Linear Voltage Regulator – SiS293050

Positive Fixed 5V 0.3A Ultra-Low Dropout Voltage Regulator in bare die form

Rev 1.0
29/04/24

Description

The SiS293050 low-noise, low dropout, high precision linear regulator operates with up to 12V input and provides 300mA output current. Typical output noise is 44µV_{RMS} with dropout voltage 270mV at 150mA load. The SiS293050 is highly accurate over temperature and exhibits excellent load and line transient response. Ruggedized features include internal output current limiting; short-circuit protection and thermal overload protection. Very small die size enables high integration.

Features:

- Low Temperature Coefficient: ±100ppm/°C
- Low Dropout: 270mV at 150mA
- ± 3% Voltage Accuracy at 300mA load
- Excellent Line Regulation: 0.05%/V
- Low Noise (10Hz to 100kHz): 44µV_{RMS}
- High PSRR: 60dB Range to 10kHz
- Input Voltage up to 12V (absolute max 14V)
- Low Quiescent Current: 8µA.

Ordering Information

The following part suffixes apply:

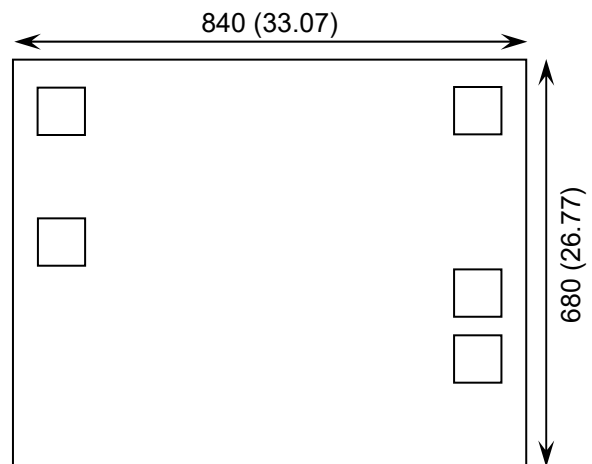
- No suffix - MIL-STD-883 /2010B Visual Inspection
- “H” - MIL-STD-883 /2010B Visual Inspection + MIL-PRF-38534 Class H LAT
- “K” - MIL-STD-883 /2010A Visual Inspection (Space) + MIL-PRF-38534 Class K LAT

LAT = Lot Acceptance Test.

For further information on LAT process flows see below.

www.siliconsupplies.com/quality/bare-die-lot-qualification

Die Dimensions in µm (mils)



Supply Formats:

- Default – Die in Waffle Pack (400 per tray capacity)
- Sawn Wafer on Tape – On request
- Unsawn Wafer – On request
- Tape & Reel – On request
- In Metal or Ceramic package – On request

Mechanical Specification

Die Size (Unsawn)	840 x 680 33.07 x 26.77	µm mils
Minimum Bond Pad Size	70 x 70 2.75 x 2.75	µm mils
Die Thickness	350 (±20) 13.78 (±0.79)	µm mils
Top Metal Composition	Al 99.5% Cu 0.5% 2µm	
Back Metal Composition	Si	

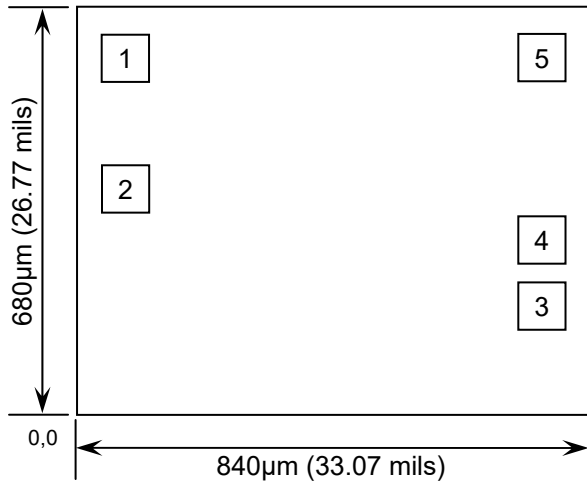




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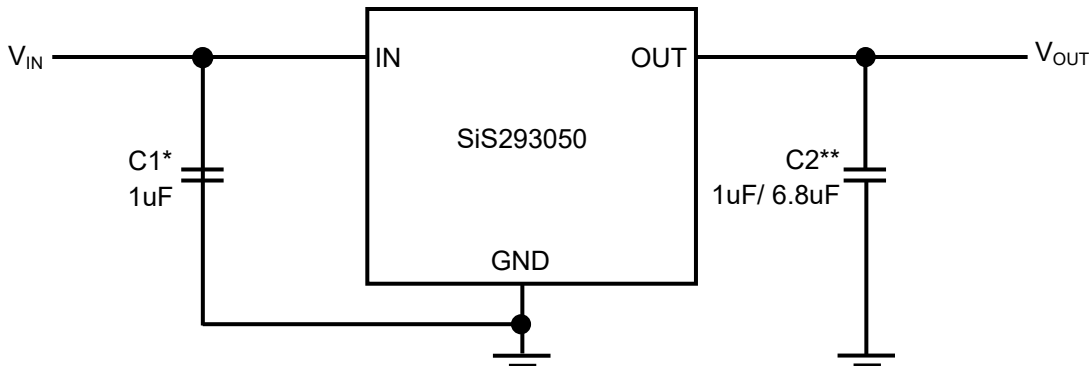
Pad Layout and Functions



PAD	FUNCTION	COORDINATES (µm)		DESCRIPTION
		X	Y	
1	V _{OUT}	75	545	Regulator Output. Requires 1µF low-ESR capacitor to GND for stable operation.
2	NC	75	346.36	Not Connected
3	NC	705.005	168.265	Not Connected
4	GND	705.005	268.27	Ground pin.
5	V _{IN}	705.005	544.995	Supply Input. Connect to power source (6V to 12V). Bypass with 1µF capacitor to GND.

CONNECT CHIP BACK TO V_{IN}

Typical Application



* C1 Input capacitor is recommended for all applications

** C2 is recommended for stability. 1µF Tantalum capacitor or 6.8µF ceramic capacitor is recommended.





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Absolute Maximum Ratings¹

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	V_{IN}	14V	V
Power Dissipation ²	P_D	Internally Limited	
Operating Junction Temperature ³	T_J	-40 to 125	°C
Storage Temperature	T_{STG}	-65 to 150	°C
Thermal Resistance (Assembled in SOT-89-3)	$R_{\theta JA}$	93.4	°C/W
ESD Capability(HBM)	V_{ESD}	2	kV

Recommended Operating Conditions

PARAMETER	SYMBOL	MIN	MAX	UNIT
Input Voltage	V_{IN}	6	12	V
Output Current	I_{OUT}	10	300	mA
Operating Junction Temperature Range ³	T_J	-40 to 125		°C

DC Electrical Characteristics $C_{IN} C_{OUT} = 1\mu F, T_J = 25^\circ C$ (unless noted otherwise)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Output Voltage	V_{OUT}	$V_{IN} = 6V, 1mA \leq I_{OUT} \leq 10mA$	4.9	5.0	5.1	V
Line Regulation ⁴	ΔV_{OUT}	$I_{OUT} = 10mA, 4V \leq V_{IN} \leq 6V$	-	0.05	0.2	% / V_{OUT}
Load Regulation ⁴	ΔV_{OUT}	$V_{IN} = 6V, 1mA \leq I_{OUT} \leq 300mA$	-	60	-	mV
Output Voltage Accuracy		$I_{OUT} = 300mA$	-3	-	+3	%
Dropout Voltage	V_{DO}	$I_{OUT} = 150mA$	-	270	-	mV
Supply Current	I_S	$V_{IN} = 6V, V_{OUT}$ Floating	-	8	15	μA
Output Voltage Noise	V_n	BW = 10Hz~100kHz	-	44	-	μV_{RMS}
	$\frac{\Delta V_{OUT}}{T \cdot V_{OUT}}$	$I_{OUT} = 10mA$	-	±100	-	ppm/°C
Power Supply Rejection Ratio	PSRR	f = 100Hz, Ripple = 0.5Vp-p $V_{IN} = 6V$	-	60	-	dB
Maximum Output Current	I_{LIMIT}	$V_{IN} - V_{OUT} = 1V$	-	-	340	mA
Thermal Shutdown Threshold	T_{SHDN}		-	155	-	°C
Thermal Shutdown Hysteresis	ΔT_{SHDN}		-	25	-	°C

1. Operation above absolute maximum rating may cause device failure. Operation at the absolute maximum ratings, for extended periods, may reduce device reliability. 2. Maximum allowable power dissipation of any T_A (ambient temperature) is $P_{DMAX} = (T_{JMAX} - T_A) / \theta_{JA}$. Exceeding the maximum allowable power dissipation will result in excessive die temperature and the regulator will go into thermal shutdown 3. This IC includes over temperature protection to protect the device during momentary overload conditions. Junction temperature will exceed 125°C when over temperature protection is active. Continuous operation above the specified maximum operating junction temperature may impair device reliability. 4. Regulation is measured at a constant junction temperature, using pulse testing with a low duty cycle.





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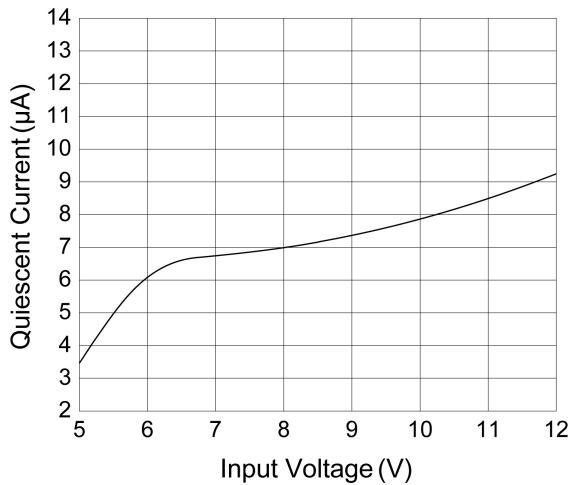


Figure 1 – Quiescent Current VS Input Voltage

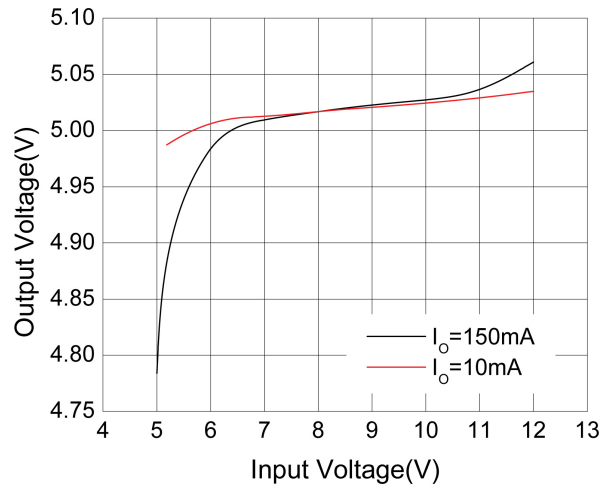


Figure 2 – Input Voltage VS Output Voltage

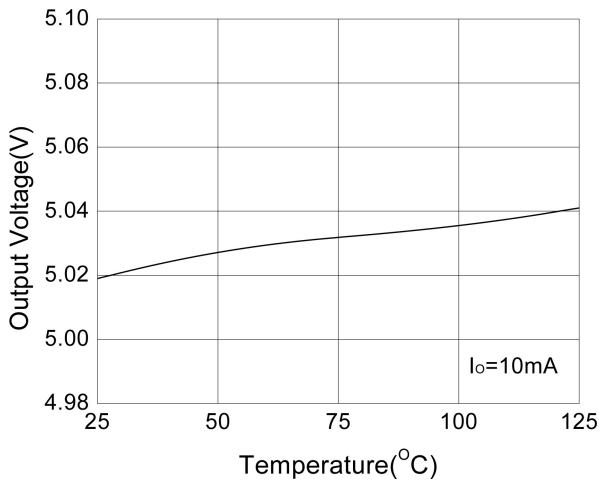


Figure 3 – Output Voltage VS Temperature

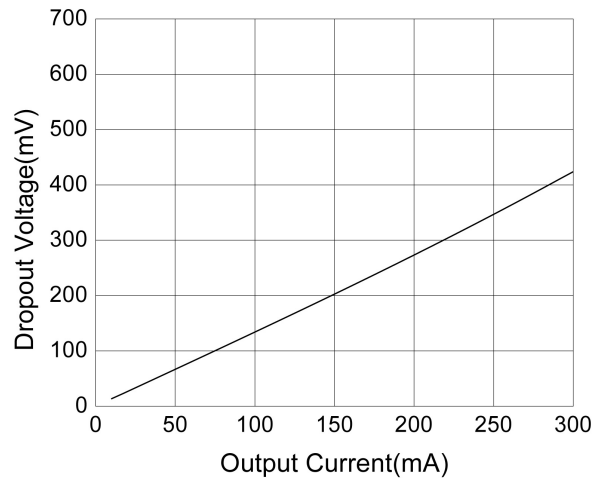


Figure 4 – Dropout Voltage VS Output Current





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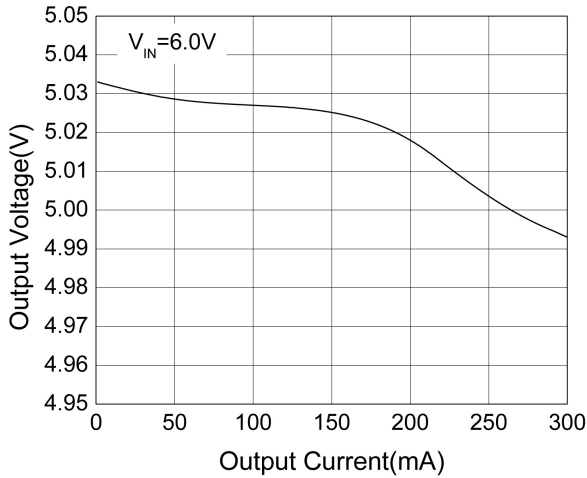


Figure 5 – Output Voltage VS Output Current

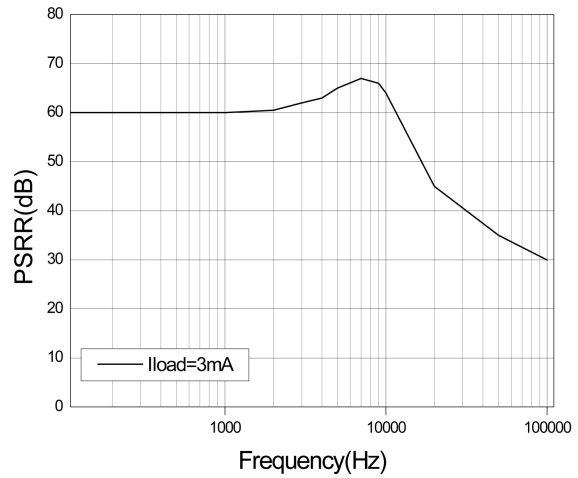


Figure 6 – PSRR VS Frequency

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